

<Intelligent Power Modules>

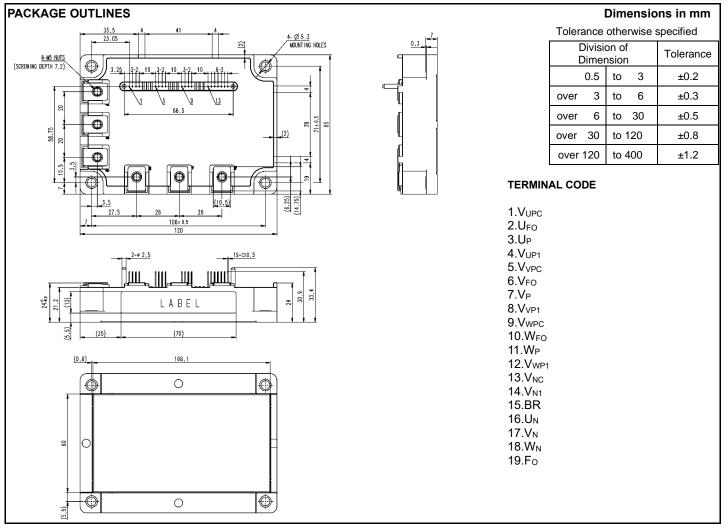
PM150RG1C120

FLAT-BASE TYPE INSULATED PACKAGE

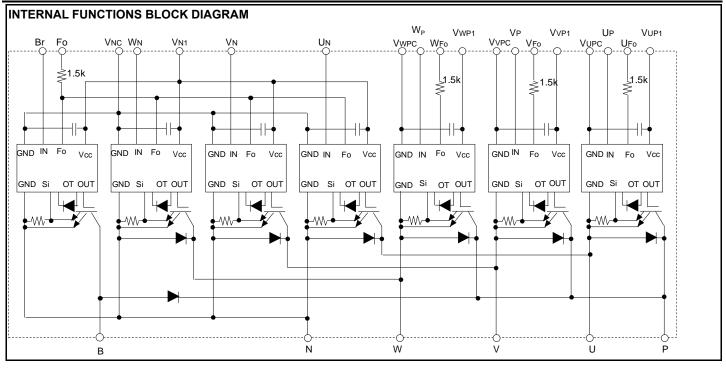
FEATURE a) Adopting Full-Gate CSTBT[™] chip. b) The over-temperature protection which detects the chip surface temperature of CSTBT[™] is adopted. c) Error output signal is available from each protection upper and lower arm of IPM. d) Outputting an error signal corresponding to the abnormal state (error mode identification) UL Recognized under UL1557, File No. E323585 This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU)2015/863.

APPLICATION

General purpose inverter, servo drives and other motor controls



1



MAXIMUM RATINGS (Tvj = 25°C, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Conditions	Ratings	Unit
V _{CES}	Collector-Emitter Voltage	V _D =15 V, V _{CIN} =15 V	1200	V
I _C	Collector Current	T _c =25 °C	150	
I _{CRM}		Pulse	300	A
P _{tot}	Total Power Dissipation	T _c =25 °C	961	W
l _E	Emitter Current	T _c =25 °C	150	
I _{ERM}	(Free-wheeling Diode Forward current)	Pulse	300	A
Τvj	Junction Temperature	(Note5)	-20 ~ +150	°C

*: Tc measurement point is just under the chip.

BRAKE PART

Symbol	Parameter	Conditions	Ratings	Unit
V _{CES}	Collector-Emitter Voltage	V _D =15 V, V _{CIN} =15 V	1200	V
I _C		T _c =25 °C	75	
I _{CRM}	Collector Current	Pulse	150	A
P _{tot}	Total Power Dissipation	T _c =25 °C	595	W
V _{R(DC)}	Diode Rated Reverse DC Voltage	T _c =25 °C	1200	V
IF	Diode Forward Current	T _c =25 °C	75	А
Tvj	Junction Temperature	(Note5)	-20 ~ +150	°C

*: Tc measurement point is just under the chip.

CONTROL PART

Symbol	Parameter	Conditions	Ratings	Unit
VD	Supply Voltage	Applied between: V_{UP1} - V_{UPC} , V_{VP1} - V_{VPC} , V_{WP1} - V_{WPC} , V_{N1} - V_{NC}	20	V
V _{CIN}	Input Voltage	Applied between: U _P -V _{UPC} , V _P -V _{VPC} , W _P -V _{WPC} , U _N , V _N , W _N , Br -V _{NC}	20	V
V _{FO}	Fault Output Supply Voltage	Applied between: U_{FO} - V_{UPC} , V_{FO} - V_{VPC} , W_{FO} - V_{WPC} , FO- V_{NC}	20	V
I _{FO}	Fault Output Current	Sink current at U_{FO} , V_{FO} , W_{FO} , Fo terminals	20	mA

TOTAL SYSTEM

Symbol	Parameter	Conditions	Ratings	Unit
V _{CC(PROT)}	Supply Voltage Protected by SC	V _D =13.5 V∼16.5 V, Inverter Part, Tvj=+125°C start	800	V
T _{stg}	Storage Temperature	-	-40 ~ +125	°C
Tc	Operating Case Temperature	(Note5)	-20 ~ +125	°C
V _{isol}	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base plate, AC 1min, RMS	2500	V

*: Tc measurement point is just under the chip.

THERMAL RESISTANCE

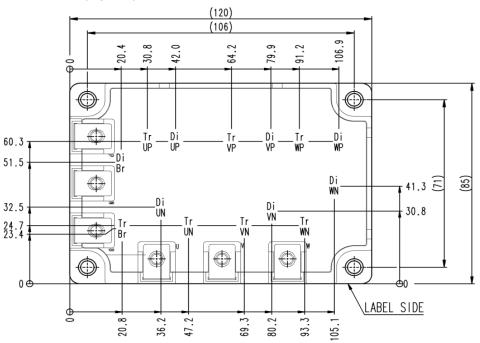
Symbol	Parameter	Conditions	Limits			Unit
	Falameter	Conditions	Min.	Тур.	Max.	Unit
R _{th(j-c)Q}	Thermal Resistance	Inverter, Junction to case, IGBT, per 1 element (Note1)	-	-	0.13	
R _{th(j-c)D}		Inverter, Junction to case, FWD, per 1 element (Note1)	-	-	0.18	K/W
$R_{th(j-c)Q}$		Brake, Junction to case, IGBT, per 1 element (Note1)	-	-	0.21	r\/ v v
$R_{th(j-c)D}$		Brake, Junction to case, FWD, per 1 element (Note1)	-	-	0.30	
R _{th(c-s)}	Contact Thermal Resistance	Case to heat sink, per 1 module,	-	8.4	-	K/kW
$\kappa_{th(c-s)}$	Contact Thermal Resistance	Thermal grease applied (Note.1, 2, 5)	-	0.4	-	n

Note1. If you use this value, $R_{th(s-a)}$ should be measured just under the chips.

Note2. Typical value is by thermally conductive grease of λ =0.9W/(m·K), D_{(C-S)}=50 \ \mu m.

CHIP LOCATION (Top view)

Dimension in mm, torelance: ±1mm



Tr**	: IGBT	
Di**	: FWD	

ELECTRICAL CHARACTERISTICS (Tvj= 25°C, unless otherwise noted)

INVERTER PART

Currente e l	Devenueter	Conditions			Limits		Unit	
Symbol	Parameter	Conditions			Min.	Тур.		Max.
				Terminal	-	-	1.9	
V		V _D =15 V, I _C =150 A	Tvj=25 °C	Chip	-	1.3	-	v
V _{CEsat}	Collector-Emitter Saturation Voltage	(-0) (Duland (Fig. 4)	T: - 405 %C	Terminal	-	-	2.15	v
		V _{CIN} =0 V, Pulsed, (Fig.1)	Tvj=125 °C	Chip	-	1.5	-	
		V_D =15 V, I _E =150 A, Tvj=25 °C V_{CIN} = 15 V, pulsed, (Fig.2) Tvj=125 °C	Tui-25 °C	Terminal	-	-	2.4	
V			TVJ-25 C	Chip	-	1.75	-	v
V _{EC}	Emitter-Collector Voltage		Tyi-125 °C	Terminal	-	-	2.65	v
			Chip	-	1.95	-		
t _{on}		V_{D} =15 V, V_{CIN} =0 V \leftrightarrow 15 V,		0.3	0.8	1.2		
t _{rr}		V _{cc} =600 V, I _c =150A,		-	0.2	0.4]	
t _{c(on)}	Switching Time	Tvj=125 °C, Inductive Load			-	0.2	0.4	μs
t _{off}	1			-	1.2	2.8		
t _{c(off)}		(Fig.3, 4)			-	0.4	1.2	
	Collector Emitter Cut off Current	V _{CE} =V _{CES} , V _D =15 V,		Tvj=25 °C	-	-	1	m (
ICES	Collector-Emitter Cut-off Current	V _{CIN} =15 V (Fig.5)		Tvj=125 °C	-	-	10	mA

BRAKE PART

Symbol	Doromotor	Conditions			Limits			1.1
Symbol	Parameter	Condition	Conditions		Min.	Тур.	Max.	Unit
		V _D =15 V, I _C =150A	Tvj=25 °C	Terminal	-	-	1.8	
V		VD-13 V, IC-130A	10]-23 C	Chip	-	1.3	-	V
V _{CEsat}	Collector-Emitter Saturation Voltage	V _{CIN} =0 V, Pulsed, (Fig.1)	Tvj=125 °C	Terminal	-	-	2.05	
				Chip	-	1.5	-	
			Tvj=25 °C	Terminal	-	-	2.4	
N/	Diada Carward Valtaga			Chip	-	1.75	-	v
V _{FM}	Diode Forward Voltage	I _F =150A	T : 405.00	Terminal	-	-	2.65	
		I VJ=125	Tvj=125 °C	Chip	-	1.95	-	
	Collector-Emitter Cut-off Current	$V_{CE}=V_{CES}, V_{D}=15 \text{ V}, V_{CIN}=15 \text{ V}$ (Fig.5)		Tvj=25 °C	-	-	1	m (
ICES				Tvj=125 °C	-	-	10	mA

ELECTRICAL CHARACTERISTICS (Tvj = 25°C, unless otherwise noted)

CONTROL PART

Symbol	Devenueter	Conditions	Conditions		Limits			
Symbol	Parameter	Conditions			Тур.	Max.	Unit	
			V _{P1} -V _{PC}	-	4	6		
		V _D =15 V, V _{CIN} =15 V	V _{N1} -V _{NC}	-	16	24]	
ID	Circuit Current	V_D =15 V, V_{CIN} =0 V \leftrightarrow 15 V, V_{CC} =800 V	V _{P1} -V _{PC}	-	42	50	mA	
		l _c =0A, Tvj=125 °C, f _c ≤20kHz	V _{N1} -V _{NC}	-	148	173	1	
$V_{th(ON)}$	Input ON Threshold Voltage	Applied between:		1.2	1.5	1.8	v	
$V_{th(OFF)}$	Input OFF Threshold Voltage	$U_{P}\text{-}V_{UPC}, V_{P}\text{-}V_{VPC}, W_{P}\text{-}V_{WPC}, U_{N}, V_{N}, W_{N},$	Br-V _{NC}	1.7	2.0	2.3	- V	
	Short Circuit Trip Level	-20≤Tvj≤125 °C, V _D =15 V (Fig.3, 6)	Inverter	300	-	-		
SC			Brake	150	-	-	A	
t _{d(SC)}	Short Circuit Current Delay Time	V _D =15 V, Tvj=125 °C (Fig.3, 6)		-	2.0	-	μs	
ОТ			Trip level	150	-	-	- °C	
OT _(hys)	Over Temperature Protection	Detect temperature of IGBT chip surface	Hysteresis	-	20	-		
UVt	Supply Circuit		Trip level	11.0	12.0	12.7	- v	
UVr	Under-Voltage Protection	-	Reset level	-	12.5	-		
I _{FO(H)}				-	-	0.01		
I _{FO(L)}	Fault Output Current	V _D =15 V, V _{FO} =15 V (Note3)		-	10	15	mA	
			OT	-	8.0	-		
t _{FO}	Fault Output Pulse Width	V _D =15 V (Note3)	UV	-	4.0	-	ms	
			SC	-	2.0	-		

Note3. Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

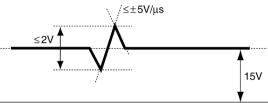
MECHANICAL RATINGS AND CHARACTERISTICS

Symbol	Parameter	Conditions		Limits		
				Тур.	Max.	Unit
Ms	Mounting Torque	Mounting part screw : M5	2.5	3.0	3.5	N•m
Mt	Mounting Torque	Main terminal part screw : M5	2.5	3.0	3.5	IN•III
m	mass	-	-	425	-	g

RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Conditions	Recommended value	Unit
V _{cc}	Supply Voltage	Applied across P-N terminals	≤ 800	V
V _D	Control Supply Voltage	Applied between : V _{UP1} -V _{UPC} , V _{VP1} -V _{VPC} , V _{WP1} -V _{WPC} ,V _{N1} -V _{NC} (Note4)	15.0±1.5	V
V _{CIN(ON)}	Input ON Voltage	Applied between :	≤ 0.8	v
V _{CIN(OFF)}	Input OFF Voltage	$U_{P}\text{-}V_{UPC}, V_{P}\text{-}V_{VPC}, W_{P}\text{-}V_{WPC}, U_{N}, V_{N}, W_{N}, Br\text{-}V_{NC}$	≥ 9.0	v
f _{PWM}	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
t _{dead}	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig.7)	≥ 2.5	μs

Note4. With ripple satisfying the following conditions: dv/dt swing ≤ ±5 V/µs, Variation ≤ 2 V peak to peak



GND

Note5. Long term performance related to thermal conductive material such as thermal grease (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under your specific application conditions. Each temperature condition (Tvj, Tc) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

PRECAUTIONS FOR TESTING

VD(a

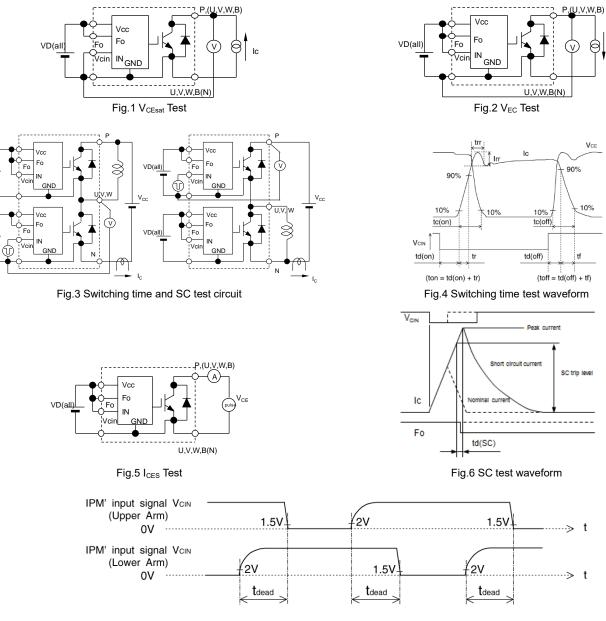
VD(all

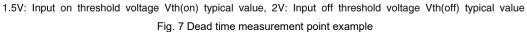
1. Before applying any control supply voltage (V_D), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.

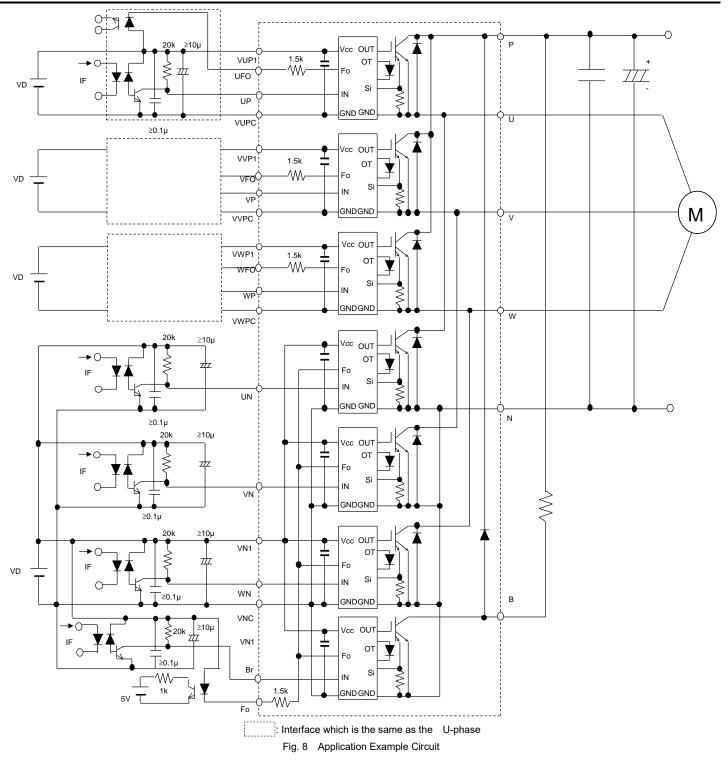
After this, the specified ON and OFF level setting for each input signal should be done.

2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V_{CES} rating of the device.

(These test should not be done by using a curve tracer or its equivalent.)

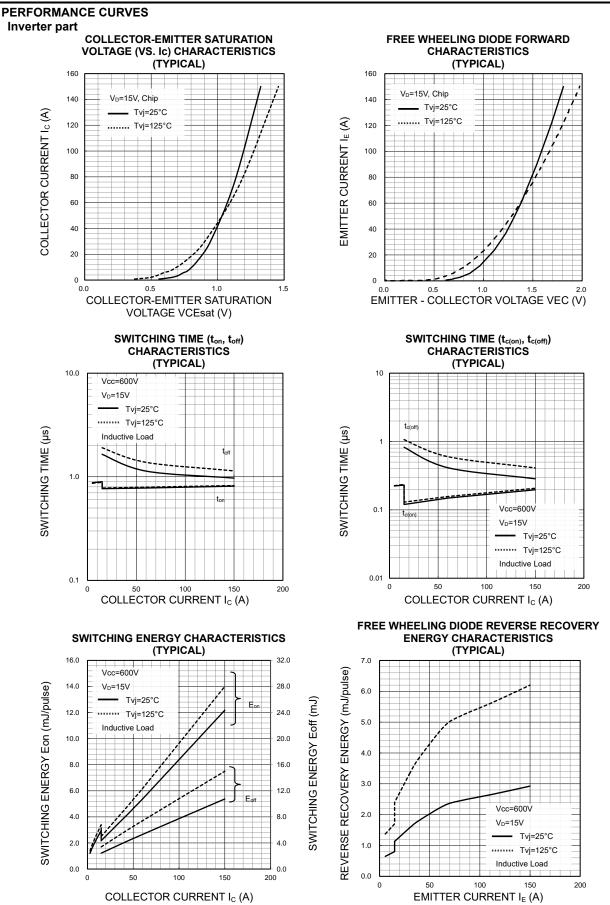


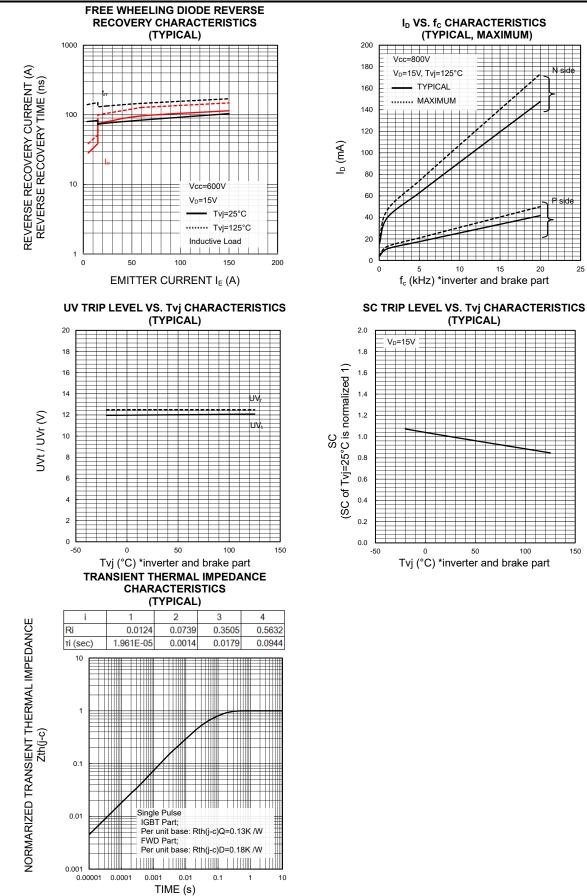




NOTES FOR STABLE AND SAFE OPERATION ;

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: t_{PLH} , $t_{PHL} \le 0.8 \mu s$, Use High CMR type.
- Slow switching opto-coupler: CTR > 100% (*can be applied to Brake part input signal, in this case, resistor should be selected properly).
- Use 4 isolated control power supplies (V_D). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.





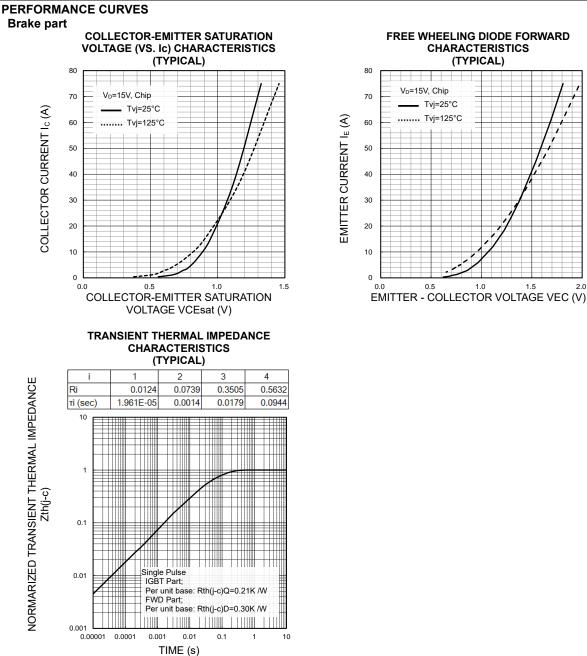
15

20

25

150

100



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

(TYPICAL)

1.0

1.5

2.0

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